

Search Notes**Application/Control No.**

10/074,304

Examiner

Christopher B. Shin

Applicant(s)/Patent under Reexamination

SHEPARD ET AL.

Art Unit

2182

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--------------------------------|---------|----------|
| 710 | 1-4, 8-14, 20-21, 62- 63 | 6-10-05 | ✓ |
| 710 | 72, 104 | | |
| 709 | 208,220 | | |
| 713 | 100 | | |
| 700 | 2-12, 20 | | |
| 712 | 1-15 | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|---------|------|
| PLUS | 6-10-05 | ✓ |
| INVENTOR SEARCHED | 6-10-05 | ✓ |
| EAST (USPGPUB, EPO, JPO, USPAT, DERWENT, IBM_TDB, USOCR) | 6-10-05 | ✓ |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|---------|----------|
| 710 | 8, 104 | 6-11-05 | ✓ |
| 700 | 2,8 | | ↓ |
| 712 | 10 | ↓ | ↓ |
| | | | |
| | | | |
| | | | |
| | | | |